Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/023,121	VAN DER VEN, ERIK
Examiner	Art Unit
PHUC H. TRAN	2668

SEARCHED					
Class	Subclass	Date	Examiner		
370	435,436 503-531	9/27/2005	PT		
375	242,35	9/27/2005	PT		
375	355,359	9/27/2005	PT		
375	360	9/27/2005	PT		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	436	12/22/2005	PT	
375	360	12/22/2005	pt	

SEARCH I (INCLUDING SEAR		·)
	DATE	EXMR
Consutted with Dang Ton	9/29/2005	PT
East	9/29/2005	PT
text search for interference	12/22/2005	РТ